

Notice of References Cited	Application/Control No. 10/593,630	Applicant(s)/Patent Under Reexamination IDE ET AL.	
	Examiner JOSE M. DIAZ	Art Unit 2879	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2005/0052129 A1	03-2005	Yamashita, Seiji	313/506
*	C	US-2006/0186802 A1	08-2006	Cok et al.	313/506
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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